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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Obsolete
Number of LABs/CLBs	2880
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	174
Number of Gates	48000
Voltage - Supply	3V ~ 3.6V, 4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 85°C (TA)
Package / Case	208-BFQFP
Supplier Device Package	208-PQFP (28x28)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/a54sx32-2pq208i">https://www.e-xfl.com/product-detail/microchip-technology/a54sx32-2pq208i</a>

## Routing Resources

Clusters and SuperClusters can be connected through the use of two innovative local routing resources called *FastConnect* and *DirectConnect*, which enable extremely fast and predictable interconnection of modules within clusters and SuperClusters (Figure 1-5 and Figure 1-6). This routing architecture also dramatically reduces the number of antifuses required to complete a circuit, ensuring the highest possible performance.

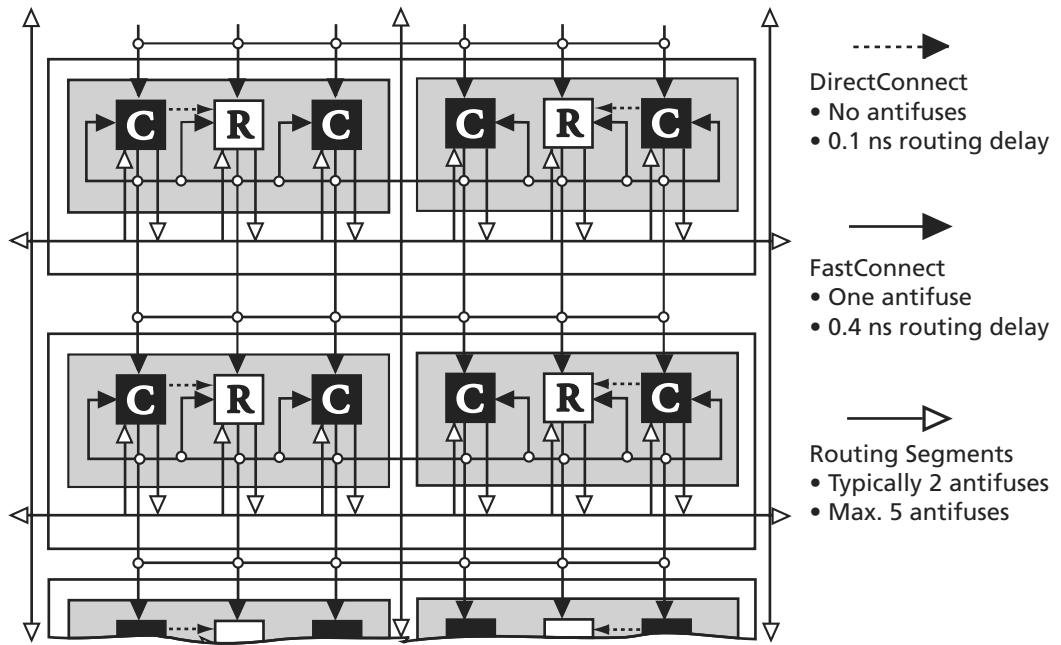


Figure 1-5 • DirectConnect and FastConnect for Type 1 SuperClusters

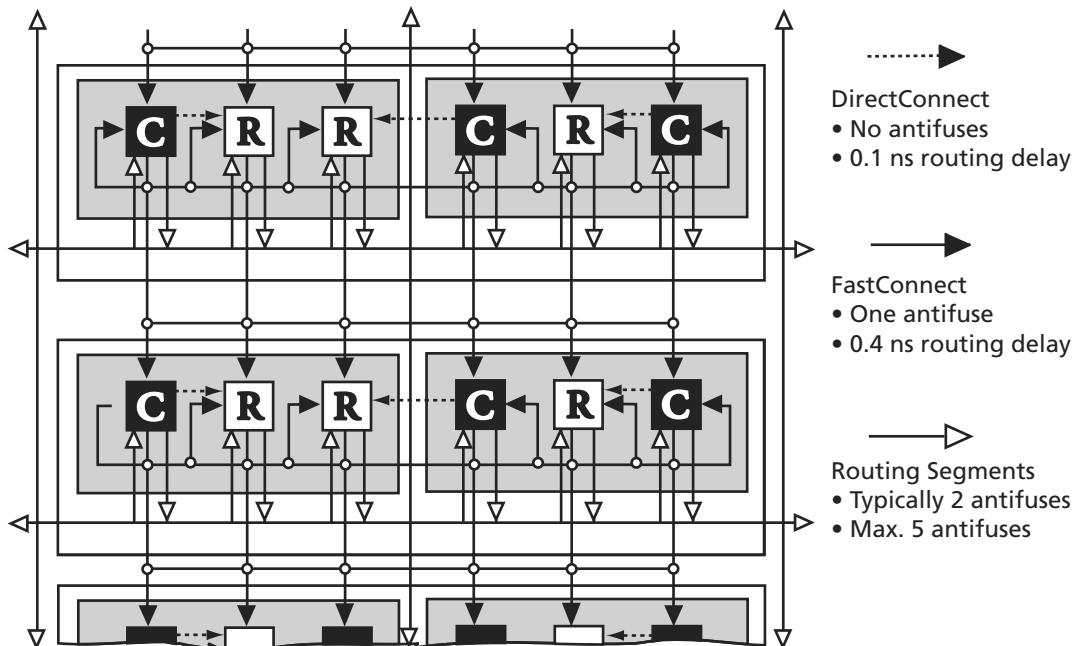


Figure 1-6 • DirectConnect and FastConnect for Type 2 SuperClusters

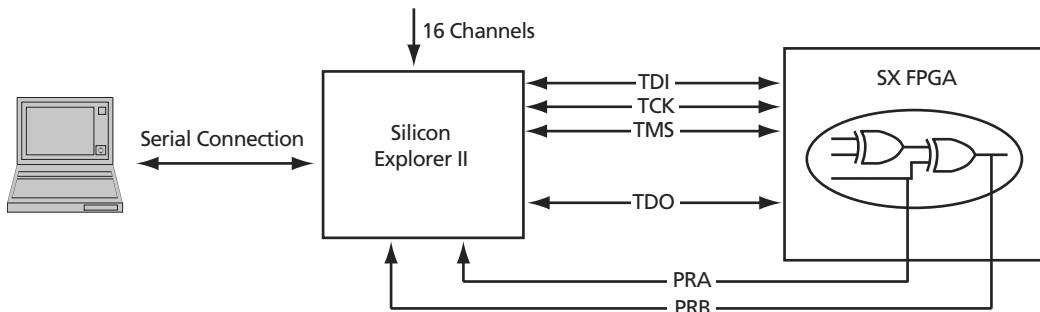


Figure 1-8 • Probe Setup

## Programming

Device programming is supported through Silicon Sculptor series of programmers. In particular, Silicon Sculptor II are compact, robust, single-site and multi-site device programmer for the PC.

With standalone software, Silicon Sculptor II allows concurrent programming of multiple units from the same PC, ensuring the fastest programming times possible. Each fuse is subsequently verified by Silicon Sculptor II to insure correct programming. In addition, integrity tests ensure that no extra fuses are programmed. Silicon Sculptor II also provides extensive hardware self-testing capability.

The procedure for programming an SX device using Silicon Sculptor II are as follows:

1. Load the .AFM file
2. Select the device to be programmed
3. Begin programming

When the design is ready to go to production, Actel offers device volume-programming services either through distribution partners or via in-house programming from the factory.

For more details on programming SX devices, refer to the *Programming Antifuse Devices* application note and the *Silicon Sculptor II User's Guide*.

## 3.3 V / 5 V Operating Conditions

Table 1-3 • Absolute Maximum Ratings<sup>1</sup>

Symbol	Parameter	Limits	Units
$V_{CCR}^2$	DC Supply Voltage <sup>3</sup>	-0.3 to + 6.0	V
$V_{CCA}^2$	DC Supply Voltage	-0.3 to + 4.0	V
$V_{CCI}^2$	DC Supply Voltage (A54SX08, A54SX16, A54SX32)	-0.3 to + 4.0	V
$V_{CCI}^2$	DC Supply Voltage (A54SX16P)	-0.3 to + 6.0	V
$V_I$	Input Voltage	-0.5 to + 5.5	V
$V_O$	Output Voltage	-0.5 to + 3.6	V
$I_{IO}$	I/O Source Sink Current <sup>3</sup>	-30 to + 5.0	mA
$T_{STG}$	Storage Temperature	-65 to +150	°C

**Notes:**

1. Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Device should not be operated outside the Recommended Operating Conditions.
2.  $V_{CCR}$  in the A54SX16P must be greater than or equal to  $V_{CCI}$  during power-up and power-down sequences and during normal operation.
3. Device inputs are normally high impedance and draw extremely low current. However, when input voltage is greater than  $V_{CC} + 0.5$  V or less than GND - 0.5 V, the internal protection diodes will forward-bias and can draw excessive current.

## PCI Compliance for the SX Family

The SX family supports 3.3 V and 5.0 V PCI and is compliant with the PCI Local Bus Specification Rev. 2.1.

Table 1-6 • A54SX16P DC Specifications (5.0 V PCI Operation)

Symbol	Parameter	Condition	Min.	Max.	Units
$V_{CCA}$	Supply Voltage for Array		3.0	3.6	V
$V_{CCR}$	Supply Voltage required for Internal Biasing		4.75	5.25	V
$V_{CCI}$	Supply Voltage for I/Os		4.75	5.25	V
$V_{IH}$	Input High Voltage <sup>1</sup>		2.0	$V_{CC} + 0.5$	V
$V_{IL}$	Input Low Voltage <sup>1</sup>		-0.5	0.8	V
$I_{IH}$	Input High Leakage Current	$V_{IN} = 2.7$		70	$\mu A$
$I_{IL}$	Input Low Leakage Current	$V_{IN} = 0.5$		-70	$\mu A$
$V_{OH}$	Output High Voltage	$I_{OUT} = -2 \text{ mA}$	2.4		V
$V_{OL}$	Output Low Voltage <sup>2</sup>	$I_{OUT} = 3 \text{ mA}, 6 \text{ mA}$		0.55	V
$C_{IN}$	Input Pin Capacitance <sup>3</sup>			10	pF
$C_{CLK}$	CLK Pin Capacitance		5	12	pF
$C_{IDSEL}$	IDSEL Pin Capacitance <sup>4</sup>			8	pF

**Notes:**

1. Input leakage currents include hi-Z output leakage for all bidirectional buffers with tristate outputs.
2. Signals without pull-up resistors must have 3 mA low output current. Signals requiring pull-up must have 6 mA; the latter include, FRAME#, IRDY#, TRDY#, DEVSEL#, STOP#, SERR#, PERR#, LOCK#, and, when used, AD[63::32], C/BE[7::4]#, PAR64, REQ64#, and ACK64#.
3. Absolute maximum pin capacitance for a PCI input is 10 pF (except for CLK).
4. Lower capacitance on this input-only pin allows for non-resistive coupling to AD[xx].

## A54SX16P AC Specifications for (PCI Operation)

Table 1-7 • A54SX16P AC Specifications for (PCI Operation)

Symbol	Parameter	Condition	Min.	Max.	Units
$I_{OH(AC)}$	Switching Current High	$0 < V_{OUT} \leq 1.4^1$	-44		mA
		$1.4 \leq V_{OUT} < 2.4^1, 2$	$-44 + (V_{OUT} - 1.4)/0.024$		mA
		$3.1 < V_{OUT} < V_{CC}^{1, 3}$		EQ 1-1 on page 1-11	
	(Test Point)	$V_{OUT} = 3.1^3$		-142	mA
$I_{OL(AC)}$	Switching Current High	$V_{OUT} \geq 2.2^1$	95		mA
		$2.2 > V_{OUT} > 0.55^1$	$V_{OUT}/0.023$		
		$0.71 > V_{OUT} > 0^{1, 3}$		EQ 1-2 on page 1-11	mA
	(Test Point)	$V_{OUT} = 0.71^3$		206	mA
$I_{CL}$	Low Clamp Current	$-5 < V_{IN} \leq -1$	$-25 + (V_{IN} + 1)/0.015$		mA
slew <sub>R</sub>	Output Rise Slew Rate	0.4 V to 2.4 V load <sup>4</sup>	1	5	V/ns
slew <sub>F</sub>	Output Fall Slew Rate	2.4 V to 0.4 V load <sup>4</sup>	1	5	V/ns

**Notes:**

1. Refer to the  $V/I$  curves in Figure 1-9 on page 1-11. Switching current characteristics for REQ# and GNT# are permitted to be one half of that specified here; i.e., half-size output drivers may be used on these signals. This specification does not apply to CLK and RST#, which are system outputs. "Switching Current High" specifications are not relevant to SERR#, INTA#, INTB#, INTC#, and INTD#, which are open drain outputs.
2. Note that this segment of the minimum current curve is drawn from the AC drive point directly to the DC drive point rather than toward the voltage rail (as is done in the pull-down curve). This difference is intended to allow for an optional N-channel pull-up.
3. Maximum current requirements must be met as drivers pull beyond the last step voltage. Equations defining these maximums (A and B) are provided with the respective diagrams in Figure 1-9 on page 1-11. The equation defined maxima should be met by design. In order to facilitate component testing, a maximum current test point is defined for each side of the output driver.
4. This parameter is to be interpreted as the cumulative edge rate across the specified range, rather than the instantaneous rate at any point within the transition range. The specified load (diagram below) is optional; i.e., the designer may elect to meet this parameter with an unloaded output per revision 2.0 of the PCI Local Bus Specification. However, adherence to both maximum and minimum parameters is now required (the maximum is no longer simply a guideline). Since adherence to the maximum slew rate was not required prior to revision 2.1 of the specification, there may be components in the market for some time that have faster edge rates; therefore, motherboard designers must bear in mind that rise and fall times faster than this specification could occur, and should ensure that signal integrity modeling accounts for this. Rise slew rate does not apply to open drain outputs.

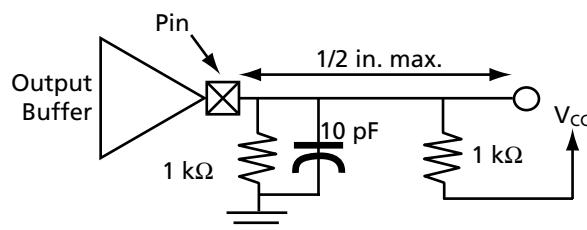


Table 1-15 • Package Thermal Characteristics

Package Type	Pin Count	$\theta_{JC}$	$\theta_{JA}$ Still Air	$\theta_{JA}$ 300 ft/min.	Units
Plastic Leaded Chip Carrier (PLCC)	84	12	32	22	°C/W
Thin Quad Flat Pack (TQFP)	144	11	32	24	°C/W
Thin Quad Flat Pack (TQFP)	176	11	28	21	°C/W
Very Thin Quad Flatpack (VQFP)	100	10	38	32	°C/W
Plastic Quad Flat Pack (PQFP) without Heat Spreader	208	8	30	23	°C/W
Plastic Quad Flat Pack (PQFP) with Heat Spreader	208	3.8	20	17	°C/W
Plastic Ball Grid Array (PBGA)	272	3	20	14.5	°C/W
Plastic Ball Grid Array (PBGA)	313	3	23	17	°C/W
Plastic Ball Grid Array (PBGA)	329	3	18	13.5	°C/W
Fine Pitch Ball Grid Array (FBGA)	144	3.8	38.8	26.7	°C/W

**Note:** SX08 does not have a heat spreader.

Table 1-16 • Temperature and Voltage Derating Factors\*

$V_{CCA}$	Junction Temperature						
	-55	-40	0	25	70	85	125
<b>3.0</b>	0.75	0.78	0.87	0.89	1.00	1.04	1.16
<b>3.3</b>	0.70	0.73	0.82	0.83	0.93	0.97	1.08
<b>3.6</b>	0.66	0.69	0.77	0.78	0.87	0.92	1.02

**Note:** \*Normalized to worst-case commercial,  $T_J = 70^\circ\text{C}$ ,  $V_{CCA} = 3.0 \text{ V}$

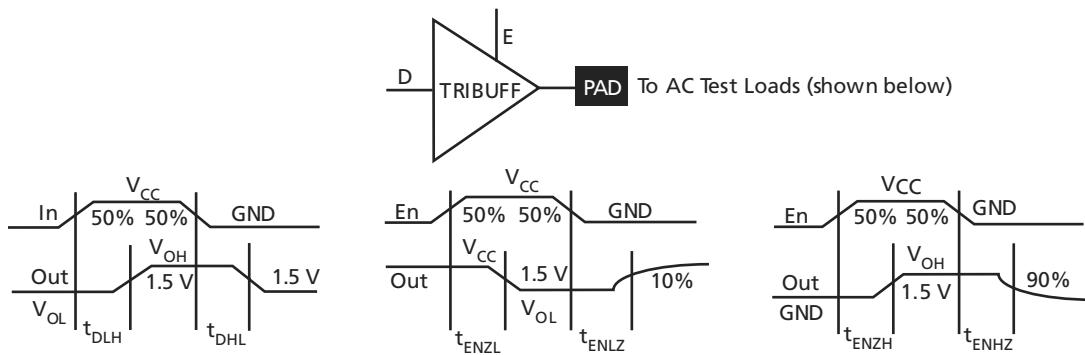


Figure 1-13 • Output Buffer Delays

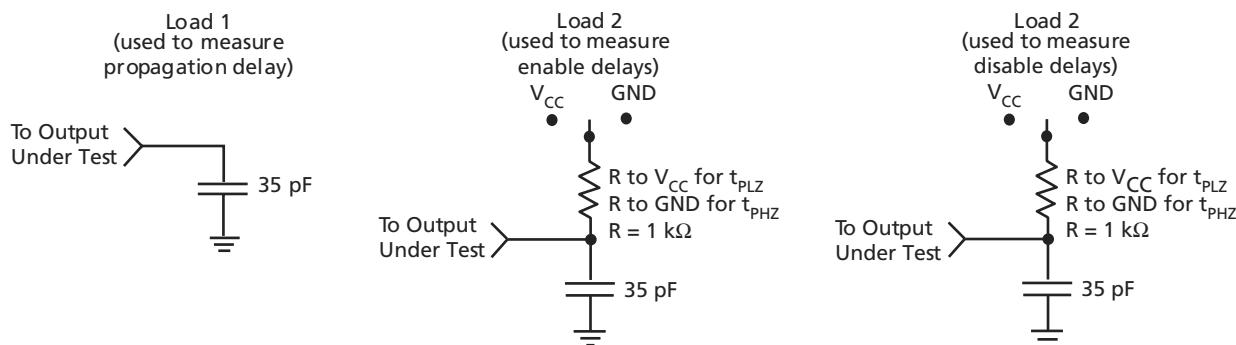


Figure 1-14 • AC Test Loads

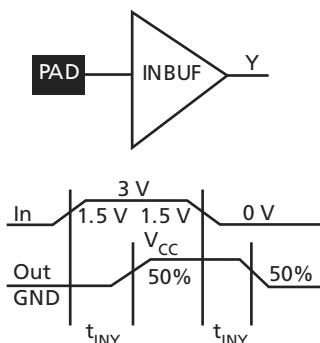


Figure 1-15 • Input Buffer Delays

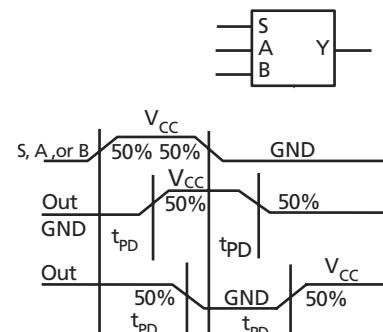


Figure 1-16 • C-Cell Delays

## Register Cell Timing Characteristics

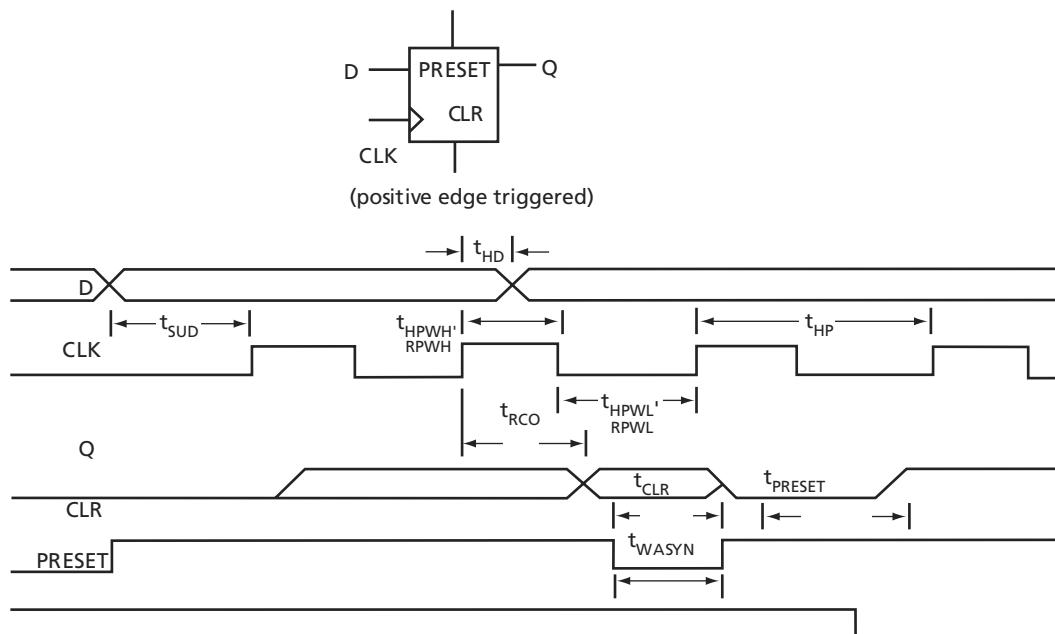


Figure 1-17 • Flip-Flops

## Timing Characteristics

Timing characteristics for SX devices fall into three categories: family-dependent, device-dependent, and design-dependent. The input and output buffer characteristics are common to all SX family members. Internal routing delays are device-dependent. Design dependency means actual delays are not determined until after placement and routing of the user's design is complete. Delay values may then be determined by using the DirectTime Analyzer utility or performing simulation with post-layout delays.

### Critical Nets and Typical Nets

Propagation delays are expressed only for typical nets, which are used for initial design performance evaluation. Critical net delays can then be applied to the most time-critical paths. Critical nets are determined by net property assignment prior to placement and routing. Up to 6% of the nets in a design may be designated as critical, while 90% of the nets in a design are typical.

### Long Tracks

Some nets in the design use long tracks. Long tracks are special routing resources that span multiple rows, columns, or modules. Long tracks employ three and sometimes five antifuse connections. This increases capacitance and resistance, resulting in longer net delays for macros connected to long tracks. Typically up to 6 percent of nets in a fully utilized device require long tracks. Long tracks contribute approximately 4 ns to 8.4 ns delay. This additional delay is represented statistically in higher fanout ( $FO = 24$ ) routing delays in the datasheet specifications section.

### Timing Derating

SX devices are manufactured in a CMOS process. Therefore, device performance varies according to temperature, voltage, and process variations. Minimum timing parameters reflect maximum operating voltage, minimum operating temperature, and best-case processing. Maximum timing parameters reflect minimum operating voltage, maximum operating temperature, and worst-case processing.

## A54SX08 Timing Characteristics

Table 1-17 • A54SX08 Timing Characteristics  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

<b>Parameter</b>	<b>Description</b>	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		<b>Units</b>
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>C-Cell Propagation Delays<sup>1</sup></b>										
$t_{PD}$	Internal Array Module	0.6		0.7		0.8		0.9		ns
<b>Predicted Routing Delays<sup>2</sup></b>										
$t_{RD1}$	FO = 1 Routing Delay, Direct Connect	0.1		0.1		0.1		0.1		ns
$t_{RD2}$	FO = 1 Routing Delay, Fast Connect	0.3		0.4		0.4		0.5		ns
$t_{RD3}$	FO = 1 Routing Delay	0.3		0.4		0.4		0.5		ns
$t_{RD4}$	FO = 2 Routing Delay	0.6		0.7		0.8		0.9		ns
$t_{RD8}$	FO = 3 Routing Delay	0.8		0.9		1.0		1.2		ns
$t_{RD12}$	FO = 4 Routing Delay	1.0		1.2		1.4		1.6		ns
$t_{RD16}$	FO = 8 Routing Delay	1.9		2.2		2.5		2.9		ns
$t_{RD32}$	FO = 12 Routing Delay	2.8		3.2		3.7		4.3		ns
<b>R-Cell Timing</b>										
$t_{RCO}$	Sequential Clock-to-Q	0.8		1.1		1.2		1.4		ns
$t_{CLR}$	Asynchronous Clear-to-Q	0.5		0.6		0.7		0.8		ns
$t_{PRESET}$	Asynchronous Preset-to-Q	0.7		0.8		0.9		1.0		ns
$t_{SUD}$	Flip-Flop Data Input Set-Up	0.5		0.5		0.7		0.8		ns
$t_{HD}$	Flip-Flop Data Input Hold	0.0		0.0		0.0		0.0		ns
$t_{WASYN}$	Asynchronous Pulse Width	1.4		1.6		1.8		2.1		ns
<b>Input Module Propagation Delays</b>										
$t_{INYH}$	Input Data Pad-to-Y HIGH	1.5		1.7		1.9		2.2		ns
$t_{INYL}$	Input Data Pad-to-Y LOW	1.5		1.7		1.9		2.2		ns
<b>Input Module Predicted Routing Delays<sup>2</sup></b>										
$t_{IRD1}$	FO = 1 Routing Delay	0.3		0.4		0.4		0.5		ns
$t_{IRD2}$	FO = 2 Routing Delay	0.6		0.7		0.8		0.9		ns
$t_{IRD3}$	FO = 3 Routing Delay	0.8		0.9		1.0		1.2		ns
$t_{IRD4}$	FO = 4 Routing Delay	1.0		1.2		1.4		1.6		ns
$t_{IRD8}$	FO = 8 Routing Delay	1.9		2.2		2.5		2.9		ns
$t_{IRD12}$	FO = 12 Routing Delay	2.8		3.2		3.7		4.3		ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.

## A54SX16P Timing Characteristics

Table 1-19 • A54SX16P Timing Characteristics  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>C-Cell Propagation Delays<sup>1</sup></b>										
$t_{PD}$	Internal Array Module	0.6		0.7		0.8		0.9		ns
<b>Predicted Routing Delays<sup>2</sup></b>										
$t_{RD1}$	FO = 1 Routing Delay, Direct Connect	0.1		0.1		0.1		0.1		ns
$t_{RD2}$	FO = 1 Routing Delay, Fast Connect	0.3		0.4		0.4		0.5		ns
$t_{RD3}$	FO = 1 Routing Delay	0.3		0.4		0.4		0.5		ns
$t_{RD4}$	FO = 2 Routing Delay	0.6		0.7		0.8		0.9		ns
$t_{RD8}$	FO = 3 Routing Delay	0.8		0.9		1.0		1.2		ns
$t_{RD12}$	FO = 4 Routing Delay	1.0		1.2		1.4		1.6		ns
$t_{RD8}$	FO = 8 Routing Delay	1.9		2.2		2.5		2.9		ns
$t_{RD12}$	FO = 12 Routing Delay	2.8		3.2		3.7		4.3		ns
<b>R-Cell Timing</b>										
$t_{RCO}$	Sequential Clock-to-Q	0.9		1.1		1.3		1.4		ns
$t_{CLR}$	Asynchronous Clear-to-Q	0.5		0.6		0.7		0.8		ns
$t_{PRESET}$	Asynchronous Preset-to-Q	0.7		0.8		0.9		1.0		ns
$t_{SUD}$	Flip-Flop Data Input Set-Up	0.5		0.5		0.7		0.8		ns
$t_{HD}$	Flip-Flop Data Input Hold	0.0		0.0		0.0		0.0		ns
$t_{WASYN}$	Asynchronous Pulse Width	1.4		1.6		1.8		2.1		ns
<b>Input Module Propagation Delays</b>										
$t_{INYH}$	Input Data Pad-to-Y HIGH	1.5		1.7		1.9		2.2		ns
$t_{INYL}$	Input Data Pad-to-Y LOW	1.5		1.7		1.9		2.2		ns
<b>Predicted Input Routing Delays<sup>2</sup></b>										
$t_{IRD1}$	FO = 1 Routing Delay	0.3		0.4		0.4		0.5		ns
$t_{IRD2}$	FO = 2 Routing Delay	0.6		0.7		0.8		0.9		ns
$t_{IRD3}$	FO = 3 Routing Delay	0.8		0.9		1.0		1.2		ns
$t_{IRD4}$	FO = 4 Routing Delay	1.0		1.2		1.4		1.6		ns
$t_{IRD8}$	FO = 8 Routing Delay	1.9		2.2		2.5		2.9		ns
$t_{IRD12}$	FO = 12 Routing Delay	2.8		3.2		3.7		4.3		ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 10 pF loading.

Table 1-19 • A54SX16P Timing Characteristics (Continued)  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

<b>Parameter</b>	<b>Description</b>	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		<b>Units</b>
		<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	
<b>Dedicated (Hardwired) Array Clock Network</b>										
$t_{HCKH}$	Input LOW to HIGH (pad to R-Cell input)	1.2		1.4		1.5		1.8		ns
$t_{HCKL}$	Input HIGH to LOW (pad to R-Cell input)	1.2		1.4		1.6		1.9		ns
$t_{HPWH}$	Minimum Pulse Width HIGH	1.4		1.6		1.8		2.1		ns
$t_{HPWL}$	Minimum Pulse Width LOW	1.4		1.6		1.8		2.1		ns
$t_{HCKSW}$	Maximum Skew		0.2		0.2		0.3		0.3	ns
$t_{HP}$	Minimum Period	2.7		3.1		3.6		4.2		ns
$f_{HMAX}$	Maximum Frequency		350		320		280		240	MHz
<b>Routed Array Clock Networks</b>										
$t_{RCKH}$	Input LOW to HIGH (light load) (pad to R-Cell input)	1.6		1.8		2.1		2.5		ns
$t_{RCKL}$	Input HIGH to LOW (Light Load) (pad to R-Cell input)	1.8		2.0		2.3		2.7		ns
$t_{RCKH}$	Input LOW to HIGH (50% load) (pad to R-Cell input)	1.8		2.1		2.5		2.8		ns
$t_{RCKL}$	Input HIGH to LOW (50% load) (pad to R-Cell input)	2.0		2.2		2.5		3.0		ns
$t_{RCKH}$	Input LOW to HIGH (100% load) (pad to R-Cell input)	1.8		2.1		2.4		2.8		ns
$t_{RCKL}$	Input HIGH to LOW (100% load) (pad to R-Cell input)	2.0		2.2		2.5		3.0		ns
$t_{RPWH}$	Min. Pulse Width HIGH	2.1		2.4		2.7		3.2		ns
$t_{RPWL}$	Min. Pulse Width LOW	2.1		2.4		2.7		3.2		ns
$t_{RCKSW}$	Maximum Skew (light load)		0.5		0.5		0.5		0.7	ns
$t_{RCKSW}$	Maximum Skew (50% load)		0.5		0.6		0.7		0.8	ns
$t_{RCKSW}$	Maximum Skew (100% load)		0.5		0.6		0.7		0.8	ns
<b>TTL Output Module Timing</b>										
$t_{DLH}$	Data-to-Pad LOW to HIGH	2.4		2.8		3.1		3.7		ns
$t_{DHL}$	Data-to-Pad HIGH to LOW	2.3		2.9		3.2		3.8		ns
$t_{ENZL}$	Enable-to-Pad, Z to L	3.0		3.4		3.9		4.6		ns
$t_{ENZH}$	Enable-to-Pad, Z to H	3.3		3.8		4.3		5.0		ns
$t_{ENLZ}$	Enable-to-Pad, L to Z	2.3		2.7		3.0		3.5		ns
$t_{ENHZ}$	Enable-to-Pad, H to Z	2.8		3.2		3.7		4.3		ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 10 pF loading.

Table 1-20 • A54SX32 Timing Characteristics (Continued)  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

<b>Parameter</b>	<b>Description</b>	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		<b>Units</b>
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Dedicated (Hardwired) Array Clock Network</b>										
$t_{HCKH}$	Input LOW to HIGH (pad to R-Cell input)		1.9		2.1		2.4		2.8	ns
$t_{HCKL}$	Input HIGH to LOW (pad to R-Cell input)		1.9		2.1		2.4		2.8	ns
$t_{HPWH}$	Minimum Pulse Width HIGH	1.4		1.6		1.8		2.1		ns
$t_{HPWL}$	Minimum Pulse Width LOW	1.4		1.6		1.8		2.1		ns
$t_{HCKSW}$	Maximum Skew		0.3		0.4		0.4		0.5	ns
$t_{HP}$	Minimum Period	2.7		3.1		3.6		4.2		ns
$f_{HMAX}$	Maximum Frequency		350		320		280		240	MHz
<b>Routed Array Clock Networks</b>										
$t_{RCKH}$	Input LOW to HIGH (light load) (pad to R-Cell input)		2.4		2.7		3.0		3.5	ns
$t_{RCKL}$	Input HIGH to LOW (light load) (pad to R-Cell input)		2.4		2.7		3.1		3.6	ns
$t_{RCKH}$	Input LOW to HIGH (50% load) (pad to R-Cell input)		2.7		3.0		3.5		4.1	ns
$t_{RCKL}$	Input HIGH to LOW (50% load) (pad to R-Cell input)		2.7		3.1		3.6		4.2	ns
$t_{RCKH}$	Input LOW to HIGH (100% load) (pad to R-Cell input)		2.7		3.1		3.5		4.1	ns
$t_{RCKL}$	Input HIGH to LOW (100% load) (pad to R-Cell input)		2.8		3.2		3.6		4.3	ns
$t_{RPWH}$	Min. Pulse Width HIGH	2.1		2.4		2.7		3.2		ns
$t_{RPWL}$	Min. Pulse Width LOW	2.1		2.4		2.7		3.2		ns
$t_{RCKSW}$	Maximum Skew (light load)		0.85		0.98		1.1		1.3	ns
$t_{RCKSW}$	Maximum Skew (50% load)		1.23		1.4		1.6		1.9	ns
$t_{RCKSW}$	Maximum Skew (100% load)		1.30		1.5		1.7		2.0	ns
<b>TTL Output Module Timing<sup>3</sup></b>										
$t_{DLH}$	Data-to-Pad LOW to HIGH		1.6		1.9		2.1		2.5	ns
$t_{DHL}$	Data-to-Pad HIGH to LOW		1.6		1.9		2.1		2.5	ns
$t_{ENZL}$	Enable-to-Pad, Z to L		2.1		2.4		2.8		3.2	ns
$t_{ENZH}$	Enable-to-Pad, Z to H		2.3		2.7		3.1		3.6	ns
$t_{ENLZ}$	Enable-to-Pad, L to Z		1.4		1.7		1.9		2.2	ns
$t_{ENHZ}$	Enable-to-Pad, H to Z		1.3		1.5		1.7		2.0	ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 35 pF loading, except  $t_{ENLZ}$  and  $t_{ENZH}$ . For  $t_{ENLZ}$  and  $t_{ENZH}$  the loading is 5 pF.



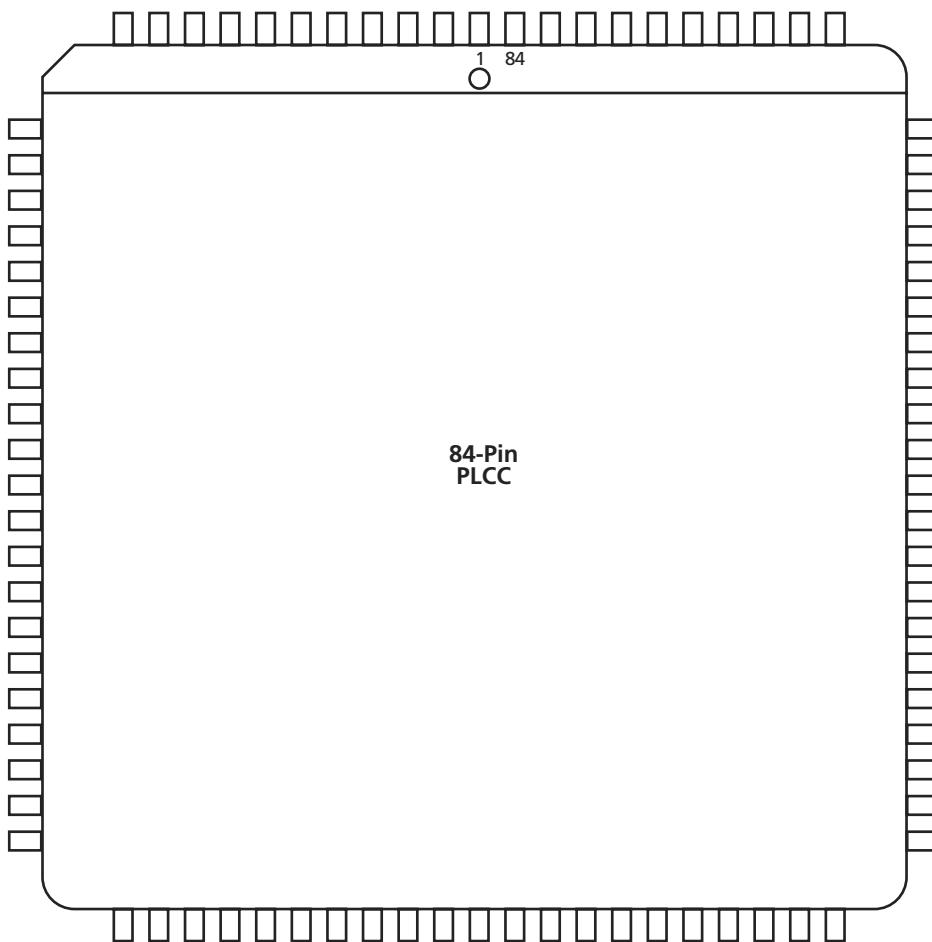
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# Package Pin Assignments

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## 84-Pin PLCC

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Figure 2-1 • 84-Pin PLCC (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

<b>208-Pin PQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
73	NC	I/O	I/O
74	I/O	I/O	I/O
75	NC	I/O	I/O
76	PRB, I/O	PRB, I/O	PRB, I/O
77	GND	GND	GND
78	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
79	GND	GND	GND
80	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
81	I/O	I/O	I/O
82	HCLK	HCLK	HCLK
83	I/O	I/O	I/O
84	I/O	I/O	I/O
85	NC	I/O	I/O
86	I/O	I/O	I/O
87	I/O	I/O	I/O
88	NC	I/O	I/O
89	I/O	I/O	I/O
90	I/O	I/O	I/O
91	NC	I/O	I/O
92	I/O	I/O	I/O
93	I/O	I/O	I/O
94	NC	I/O	I/O
95	I/O	I/O	I/O
96	I/O	I/O	I/O
97	NC	I/O	I/O
98	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
99	I/O	I/O	I/O
100	I/O	I/O	I/O
101	I/O	I/O	I/O
102	I/O	I/O	I/O
103	TDO, I/O	TDO, I/O	TDO, I/O
104	I/O	I/O	I/O
105	GND	GND	GND
106	NC	I/O	I/O
107	I/O	I/O	I/O
108	NC	I/O	I/O

**Note:** \* Note that Pin 65 in the A54SX32—PQ208 is a no connect (NC).

<b>208-Pin PQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
109	I/O	I/O	I/O
110	I/O	I/O	I/O
111	I/O	I/O	I/O
112	I/O	I/O	I/O
113	I/O	I/O	I/O
114	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
115	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
116	NC	I/O	I/O
117	I/O	I/O	I/O
118	I/O	I/O	I/O
119	NC	I/O	I/O
120	I/O	I/O	I/O
121	I/O	I/O	I/O
122	NC	I/O	I/O
123	I/O	I/O	I/O
124	I/O	I/O	I/O
125	NC	I/O	I/O
126	I/O	I/O	I/O
127	I/O	I/O	I/O
128	I/O	I/O	I/O
129	GND	GND	GND
130	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
131	GND	GND	GND
132	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
133	I/O	I/O	I/O
134	I/O	I/O	I/O
135	NC	I/O	I/O
136	I/O	I/O	I/O
137	I/O	I/O	I/O
138	NC	I/O	I/O
139	I/O	I/O	I/O
140	I/O	I/O	I/O
141	NC	I/O	I/O
142	I/O	I/O	I/O
143	NC	I/O	I/O
144	I/O	I/O	I/O

<b>208-Pin PQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
145	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
146	GND	GND	GND
147	I/O	I/O	I/O
148	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
149	I/O	I/O	I/O
150	I/O	I/O	I/O
151	I/O	I/O	I/O
152	I/O	I/O	I/O
153	I/O	I/O	I/O
154	I/O	I/O	I/O
155	NC	I/O	I/O
156	NC	I/O	I/O
157	GND	GND	GND
158	I/O	I/O	I/O
159	I/O	I/O	I/O
160	I/O	I/O	I/O
161	I/O	I/O	I/O
162	I/O	I/O	I/O
163	I/O	I/O	I/O
164	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
165	I/O	I/O	I/O
166	I/O	I/O	I/O
167	NC	I/O	I/O
168	I/O	I/O	I/O
169	I/O	I/O	I/O
170	NC	I/O	I/O
171	I/O	I/O	I/O
172	I/O	I/O	I/O
173	NC	I/O	I/O
174	I/O	I/O	I/O
175	I/O	I/O	I/O
176	NC	I/O	I/O
177	I/O	I/O	I/O
178	I/O	I/O	I/O
179	I/O	I/O	I/O
180	CLKA	CLKA	CLKA

<b>208-Pin PQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
181	CLKB	CLKB	CLKB
182	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
183	GND	GND	GND
184	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
185	GND	GND	GND
186	PRA, I/O	PRA, I/O	PRA, I/O
187	I/O	I/O	I/O
188	I/O	I/O	I/O
189	NC	I/O	I/O
190	I/O	I/O	I/O
191	I/O	I/O	I/O
192	NC	I/O	I/O
193	I/O	I/O	I/O
194	I/O	I/O	I/O
195	NC	I/O	I/O
196	I/O	I/O	I/O
197	I/O	I/O	I/O
198	NC	I/O	I/O
199	I/O	I/O	I/O
200	I/O	I/O	I/O
201	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
202	NC	I/O	I/O
203	NC	I/O	I/O
204	I/O	I/O	I/O
205	NC	I/O	I/O
206	I/O	I/O	I/O
207	I/O	I/O	I/O
208	TCK, I/O	TCK, I/O	TCK, I/O

**Note:** \* Note that Pin 65 in the A54SX32—PQ208 is a no connect (NC).

## 176-Pin TQFP

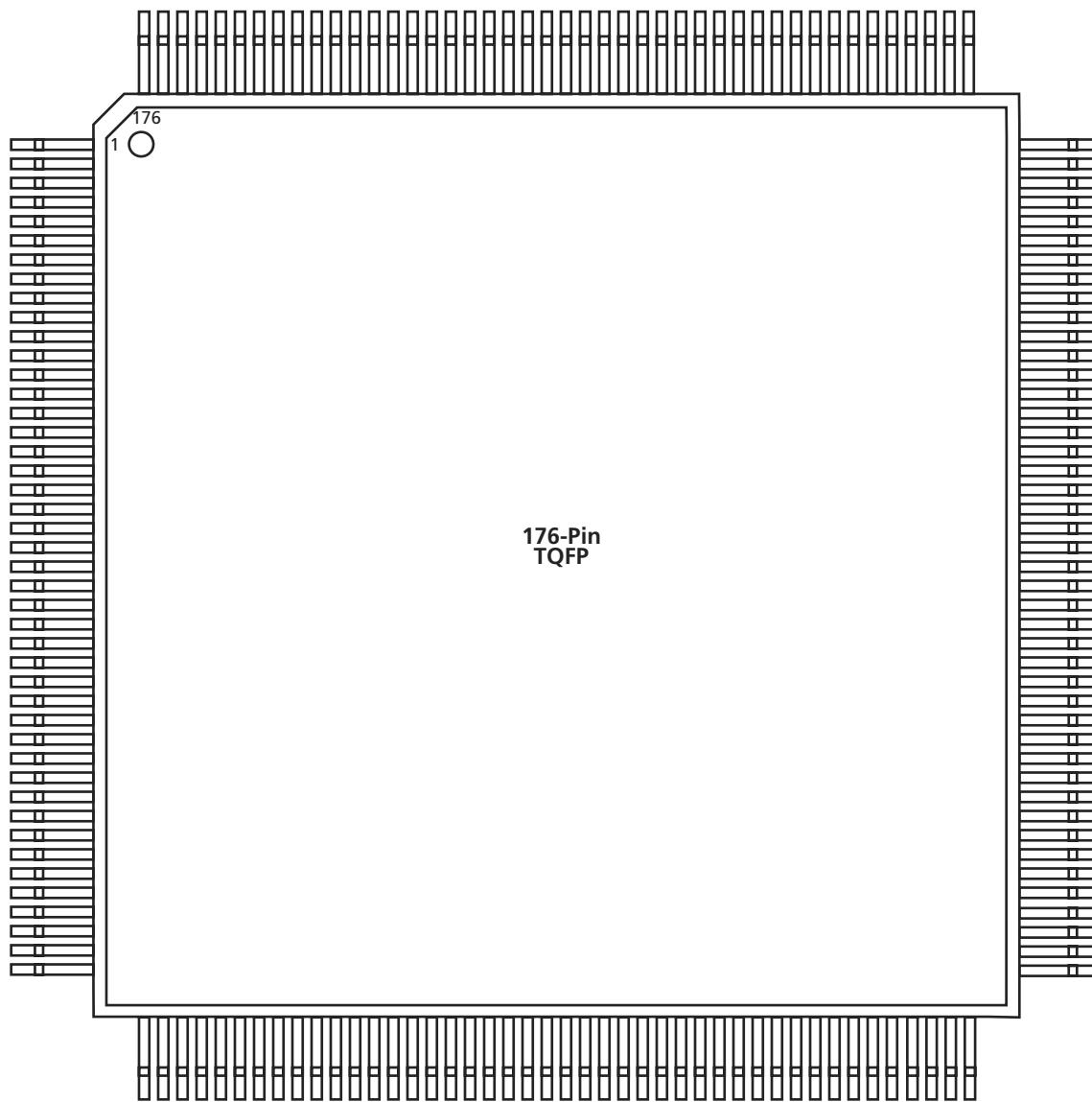


Figure 2-4 • 176-Pin TQFP (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

<b>176-Pin TQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
1	GND	GND	GND
2	TDI, I/O	TDI, I/O	TDI, I/O
3	NC	I/O	I/O
4	I/O	I/O	I/O
5	I/O	I/O	I/O
6	I/O	I/O	I/O
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	I/O	I/O	I/O
10	TMS	TMS	TMS
11	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
12	NC	I/O	I/O
13	I/O	I/O	I/O
14	I/O	I/O	I/O
15	I/O	I/O	I/O
16	I/O	I/O	I/O
17	I/O	I/O	I/O
18	I/O	I/O	I/O
19	I/O	I/O	I/O
20	I/O	I/O	I/O
21	GND	GND	GND
22	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
23	GND	GND	GND
24	I/O	I/O	I/O
25	I/O	I/O	I/O
26	I/O	I/O	I/O
27	I/O	I/O	I/O
28	I/O	I/O	I/O
29	I/O	I/O	I/O
30	I/O	I/O	I/O
31	I/O	I/O	I/O
32	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
33	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
34	I/O	I/O	I/O

<b>176-Pin TQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
35	I/O	I/O	I/O
36	I/O	I/O	I/O
37	I/O	I/O	I/O
38	I/O	I/O	I/O
39	I/O	I/O	I/O
40	NC	I/O	I/O
41	I/O	I/O	I/O
42	NC	I/O	I/O
43	I/O	I/O	I/O
44	GND	GND	GND
45	I/O	I/O	I/O
46	I/O	I/O	I/O
47	I/O	I/O	I/O
48	I/O	I/O	I/O
49	I/O	I/O	I/O
50	I/O	I/O	I/O
51	I/O	I/O	I/O
52	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
53	I/O	I/O	I/O
54	NC	I/O	I/O
55	I/O	I/O	I/O
56	I/O	I/O	I/O
57	NC	I/O	I/O
58	I/O	I/O	I/O
59	I/O	I/O	I/O
60	I/O	I/O	I/O
61	I/O	I/O	I/O
62	I/O	I/O	I/O
63	I/O	I/O	I/O
64	PRB, I/O	PRB, I/O	PRB, I/O
65	GND	GND	GND
66	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
67	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
68	I/O	I/O	I/O

100-Pin VQFP		
Pin Number	A54SX08 Function	A54SX16, A54SX16P Function
1	GND	GND
2	TDI, I/O	TDI, I/O
3	I/O	I/O
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	TMS	TMS
8	V <sub>CCI</sub>	V <sub>CCI</sub>
9	GND	GND
10	I/O	I/O
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	I/O	I/O
15	I/O	I/O
16	I/O	I/O
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	V <sub>CCI</sub>	V <sub>CCI</sub>
21	I/O	I/O
22	I/O	I/O
23	I/O	I/O
24	I/O	I/O
25	I/O	I/O
26	I/O	I/O
27	I/O	I/O
28	I/O	I/O
29	I/O	I/O
30	I/O	I/O
31	I/O	I/O
32	I/O	I/O
33	I/O	I/O
34	PRB, I/O	PRB, I/O

100-Pin VQFP		
Pin Number	A54SX08 Function	A54SX16, A54SX16P Function
35	V <sub>CCA</sub>	V <sub>CCA</sub>
36	GND	GND
37	V <sub>CCR</sub>	V <sub>CCR</sub>
38	I/O	I/O
39	HCLK	HCLK
40	I/O	I/O
41	I/O	I/O
42	I/O	I/O
43	I/O	I/O
44	V <sub>CCI</sub>	V <sub>CCI</sub>
45	I/O	I/O
46	I/O	I/O
47	I/O	I/O
48	I/O	I/O
49	TDO, I/O	TDO, I/O
50	I/O	I/O
51	GND	GND
52	I/O	I/O
53	I/O	I/O
54	I/O	I/O
55	I/O	I/O
56	I/O	I/O
57	V <sub>CCA</sub>	V <sub>CCA</sub>
58	V <sub>CCI</sub>	V <sub>CCI</sub>
59	I/O	I/O
60	I/O	I/O
61	I/O	I/O
62	I/O	I/O
63	I/O	I/O
64	I/O	I/O
65	I/O	I/O
66	I/O	I/O
67	V <sub>CCA</sub>	V <sub>CCA</sub>
68	GND	GND

100-Pin VQFP		
Pin Number	A54SX08 Function	A54SX16, A54SX16P Function
69	GND	GND
70	I/O	I/O
71	I/O	I/O
72	I/O	I/O
73	I/O	I/O
74	I/O	I/O
75	I/O	I/O
76	I/O	I/O
77	I/O	I/O
78	I/O	I/O
79	I/O	I/O
80	I/O	I/O
81	I/O	I/O
82	V <sub>CCI</sub>	V <sub>CCI</sub>
83	I/O	I/O
84	I/O	I/O
85	I/O	I/O
86	I/O	I/O
87	CLKA	CLKA
88	CLKB	CLKB
89	V <sub>CCR</sub>	V <sub>CCR</sub>
90	V <sub>CCA</sub>	V <sub>CCA</sub>
91	GND	GND
92	PRA, I/O	PRA, I/O
93	I/O	I/O
94	I/O	I/O
95	I/O	I/O
96	I/O	I/O
97	I/O	I/O
98	I/O	I/O
99	I/O	I/O
100	TCK, I/O	TCK, I/O

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
H20	I/O
H22	V <sub>CCI</sub>
H24	I/O
J1	I/O
J3	I/O
J5	I/O
J7	NC
J9	I/O
J11	I/O
J13	CLKA
J15	I/O
J17	I/O
J19	I/O
J21	GND
J23	I/O
J25	I/O
K2	I/O
K4	I/O
K6	I/O
K8	V <sub>CCI</sub>
K10	I/O
K12	I/O
K14	I/O
K16	I/O
K18	I/O
K20	V <sub>CCA</sub>
K22	I/O
K24	I/O
L1	I/O
L3	I/O
L5	I/O
L7	I/O
L9	I/O
L11	I/O
L13	GND
L15	I/O
L17	I/O
L19	I/O
L21	I/O
L23	I/O

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
L25	I/O
M2	I/O
M4	I/O
M6	I/O
M8	I/O
M10	I/O
M12	GND
M14	GND
M16	V <sub>CCI</sub>
M18	I/O
M20	I/O
M22	I/O
M24	I/O
N1	I/O
N3	V <sub>CCA</sub>
N5	V <sub>CCR</sub>
N7	I/O
N9	V <sub>CCI</sub>
N11	GND
N13	GND
N15	GND
N17	I/O
N19	I/O
N21	I/O
N23	V <sub>CCR</sub>
N25	V <sub>CCA</sub>
P2	I/O
P4	I/O
P6	I/O
P8	I/O
P10	I/O
P12	GND
P14	GND
P16	I/O
P18	I/O
P20	NC
P22	I/O
P24	I/O
R1	I/O
R3	I/O

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
R5	I/O
R7	I/O
R9	I/O
R11	I/O
R13	GND
R15	I/O
R17	I/O
R19	I/O
R21	I/O
R23	I/O
R25	I/O
T2	I/O
T4	I/O
T6	I/O
T8	I/O
T10	I/O
T12	I/O
T14	HCLK
T16	I/O
T18	I/O
T20	I/O
T22	I/O
T24	I/O
U1	I/O
U3	I/O
U5	V <sub>CCI</sub>
U7	I/O
U9	I/O
U11	I/O
U13	I/O
U15	I/O
U17	I/O
U19	I/O
U21	I/O
U23	I/O
U25	I/O
V2	V <sub>CCA</sub>
V4	I/O
V6	I/O
V8	I/O

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
V10	I/O
V12	I/O
V14	I/O
V16	NC
V18	I/O
V20	I/O
V22	V <sub>CCA</sub>
V24	V <sub>CCI</sub>
W1	I/O
W3	I/O
W5	I/O
W7	NC
W9	I/O
W11	I/O
W13	V <sub>CCI</sub>
W15	I/O
W17	I/O
W19	I/O
W21	I/O
W23	I/O
W25	I/O
Y2	I/O
Y4	I/O
Y6	I/O
Y8	I/O
Y10	I/O
Y12	I/O
Y14	I/O
Y16	I/O
Y18	I/O
Y20	NC
Y22	I/O
Y24	NC

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